

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/788,480	SHIRK ET AL.	
				Examiner	Art Unit	
				Lawrence D. Ferguson	1774	

<b>SEARCHED</b>			
Class	Subclass	Date	Examiner
428	411.1	4/06	UF
	212		
	220	/	/
	213		
	214		
	354		
	492	/	/
✓	500	/	/
359	487	11/6/06	UF
✓	494	/	/
	582	/	/
✓	586	/	/

<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
	DATE	EXMR
East Search (BRS) Inventor Search (PALM) B. Shewareged	4/06	UF
East Search Inventor Search (PACM) Vivian Chen - elastic modulus inherent + single refractive index not critical limitation.	11/6/06	UF
359,487,494,582,586	✓	✓

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner